

FORM HDP-1449 (Based on Form PTO-1449)

## PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

Sheet 1 of 1

ATTORNEY DOCKET No.	SERIAL NO.
5077-000055	09/881,235
APPLICANT	
Akira Enokihara et al.	
FILING DATE	GROUP
June 14, 2001	2817

U.S. PATENT DOCUMENTS								
Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date		
1.								

FOREIGN PATENT DOCUMENTS								
Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation Yes	n No	
1.	Dr	53-076747 A	11/30/1976	Japan		Partial		
2.	Dr	63-110618	05/16/1988	Japan		Partial	<u> </u>	
3.	DT	63-010603 A	01/23/1988	Japan		Partial		

OTHE	R DOCUME	NTS (including Author, Title, Date, Pertinent Pages, etc.)
Ref. Desig.	Examiner's Initials	
1.	Dr	Notice of Reasons of Rejection for Patent Application No. 2001-176674 mailed September 24, 2003 and English translation.

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2/4/04

Date Considered:

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FORE	IGN PATEN	IT DOCUMENTS				
Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation Yes No
1.	DT (	08065006 A	03/08/1996	Japan		Abstract
2.	DT.	2000114809 A	04/21/2000	Japan		X Abstract

OTHE	R DOCUME	NTS (including Author, Title, Date, Pertinent Pages, etc.)
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U.S. PATENT DOCUMENTS							
Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date	
1.	DT	4,028,652	06/07/1977	Wakino et al.	333/209		
2.	31	4,725,798	02/16/1988	Igarashi	333 km		

FOREIGN PATENT DOCUMENTS							
Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation Yes	No
1.	DT	63-284902	11/22/1988	Japan	HOIP 7/10	Abstract	
2.	DT	63-250201	10/18/1988	Japan	HOIP 7/10	Abstract	
3.	DT:	EP 0 859 423 A1	08/19/1998	Europe	HO1P 1/208	,	

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)		
Ref. Desig.	Examiner's Initials	
1.	DT.	Farhat Abbas et al., "Ultra-high-Q resonators for low-noise, microwave signal generation using sapphire buffer layers and superconducting thin films", Superconductor Science And Technology, Vol. 7, No. 7, July 1, 1994, pp. 495-501.

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